Notice of References Cited Application/Control No. 10/500,819 Examiner Tony Chuo Applicant(s)/Patent Under Reexamination SHIOZAKI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0180617	09-2003	Fujimoto et al.	429/231.1
	В	US-			
	С	US-			
	D	US-		•	
	E	US-			
	F	US-			
	G	US-	2	·	
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	Ļ	US-	ž.		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-289731	10-1998	Japan	Oshita et al	H01M 10/40
	0	JP 05-242891	09-1993	Japan	Noma et al	H01M 4/58
	Р	JP 2000-077071	03-2000	Japan	Numata et al	H01M 4/58
	Q					
	R					
	s					·
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.